

Single-shot readout of a flopping-mode spin qubit in a Si-MOS quantum dot

Rui-Zi Hu,^{1,2,*} Rong-Long Ma,^{1,2,*} Ming Ni,^{1,2} Yuan Zhou,^{1,2} Ning Chu,^{1,2} Wei-Zhu Liao,^{1,2} Zhen-Zhen Kong,³ Gang Cao,^{1,2} Gui-Lei Wang,^{3,4} Hai-Ou Li,^{1,2,†} and Guo-Ping Guo^{1,2,5}

Taras Patlatiuk

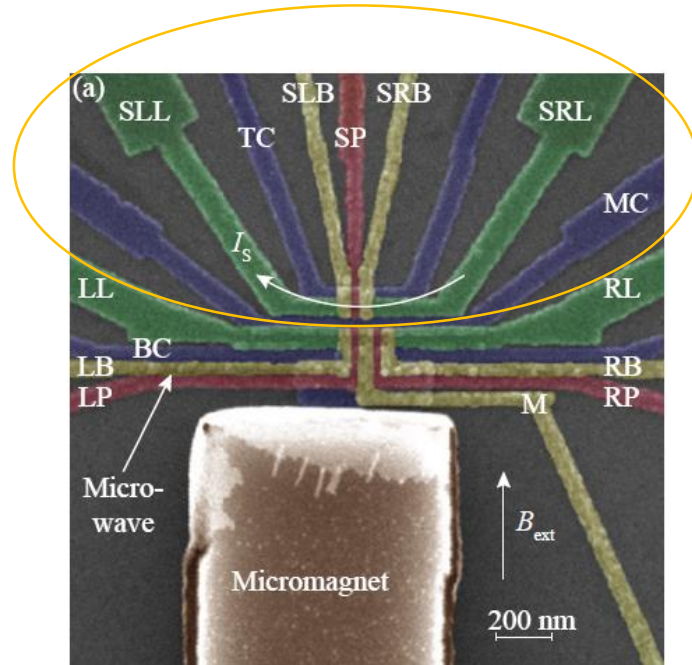
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Motivation

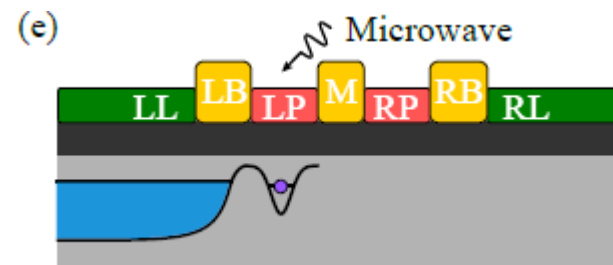
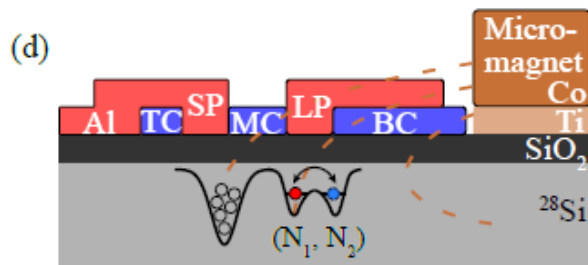
- long coherence, scalability, fab compatible
- Flopping-mode spin qubit
- Single-shot readout
- increase Rabi frequency
- constant dephasing time

Device

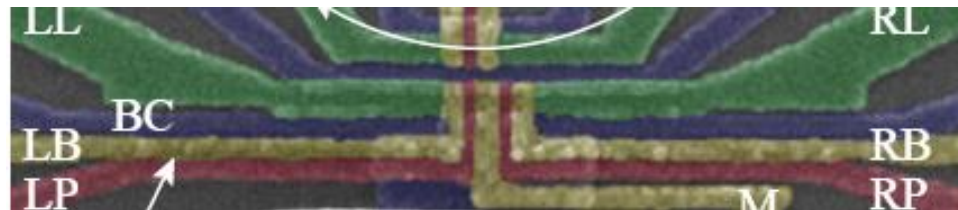
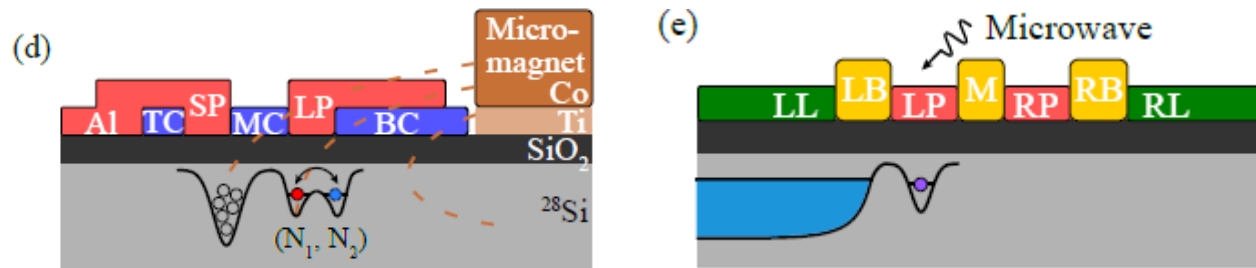
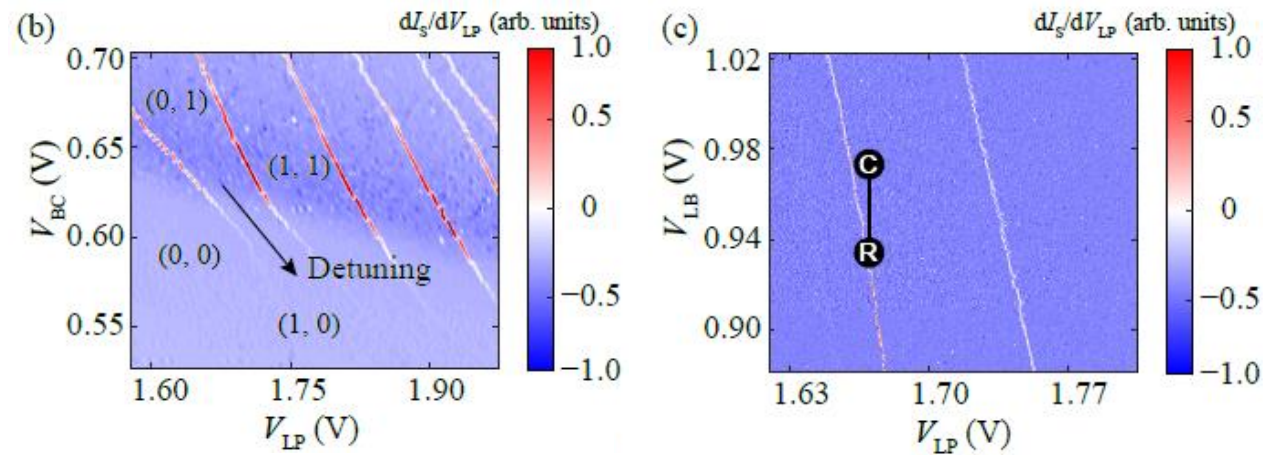
SET



- natural silicon substrate
- 60 ppm enriched Si epi layer of 70 nm
- $T = 183$ mK
- $B_{ext} = 605$ mT
- rectangular micromagnet
- fully magnetized micromagnet ~ 0.1 T/ μ m
- microwaves at LP
- channel created by MC and BC under reservoir gate LL
- dots under LP and BC

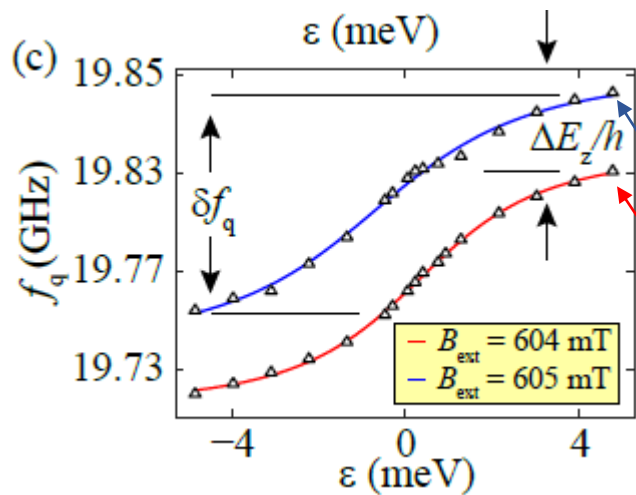
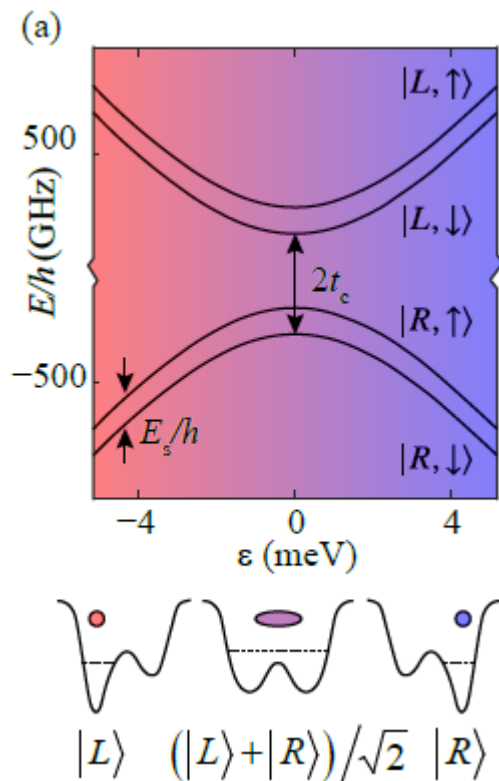
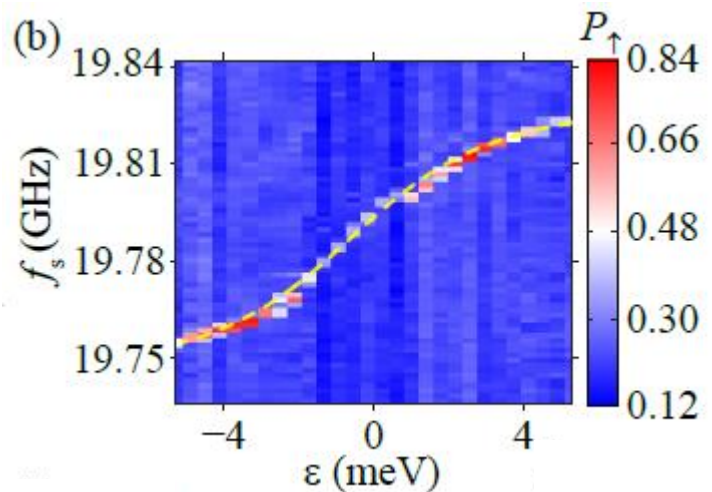


Device operation



- tunnel rate controlled by LB
- qubit pulses on LB
- Elzerman single-shot readout at R
- initialization into $|\downarrow\rangle$
- EDSR bursts with f_s at manipulation point C
- adiabatic transition between R and C

EDSR



$2t_c \approx 900$ GHz

$2t_c \approx 700$ GHz

- Elzerman readout with fixed tunnel rate of 150 Hz for $|\downarrow\rangle$
- two step pulse on gate LB
- microwave pulse ± 2 MHz around f_s for 100 μ s to identify f_q
- basis: $|L \downarrow\rangle$, $|L \uparrow\rangle$, $|R \downarrow\rangle$, $|R \uparrow\rangle$

$$H = \frac{1}{2} \begin{pmatrix} -\varepsilon - E_{z1} & -2t_{\text{SO}} & 2t_c & 0 \\ -2t_{\text{SO}} & -\varepsilon + E_{z1} & 0 & 2t_c \\ 2t_c & 0 & \varepsilon - E_{z2} & 2t_{\text{SO}} \\ 0 & 2t_c & 2t_{\text{SO}} & \varepsilon + E_{z2} \end{pmatrix}$$

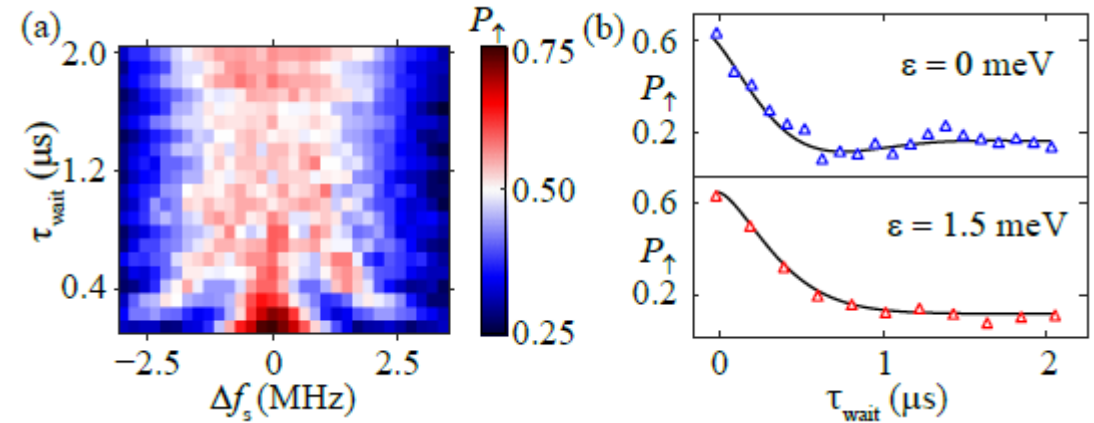
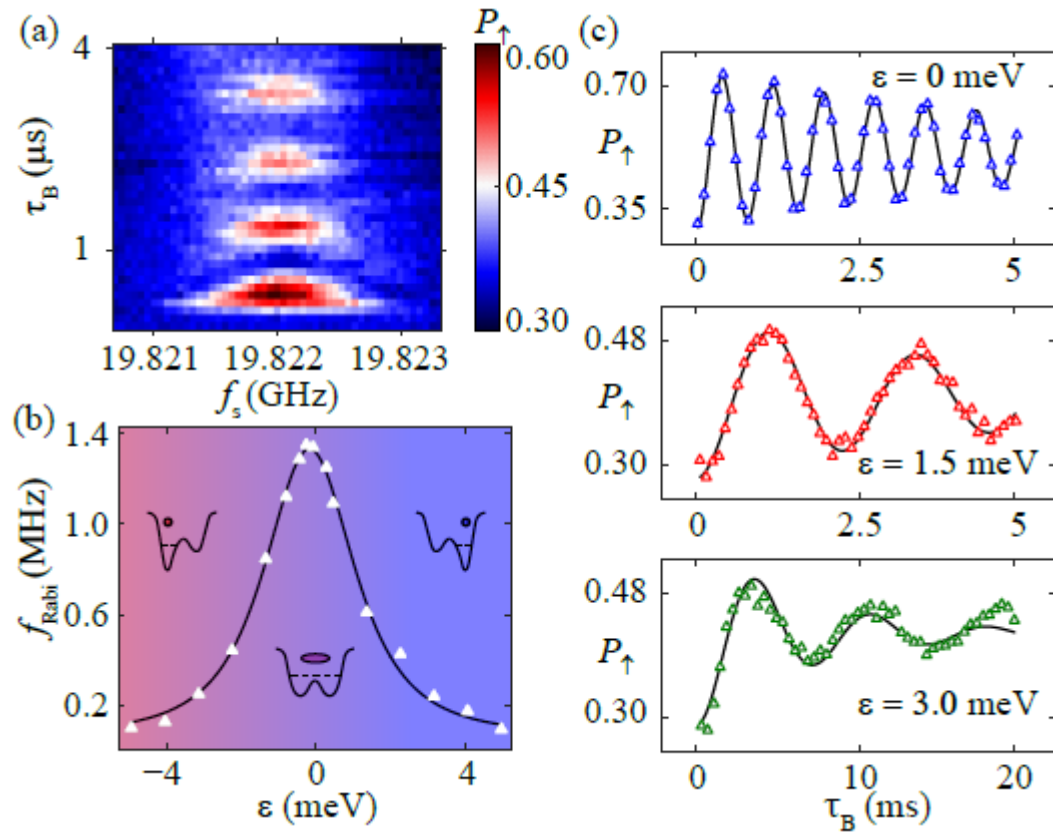
- $2t_c$ – interdot tunnel coupling
- $2t_{\text{SO}}$ – synthetic spin-orbit coupling

$$f_q \equiv E_s/h, \quad \Omega = \sqrt{\varepsilon^2 + 4t_c^2}$$

$$E_s \simeq E_z - \frac{E_z^2 - \varepsilon^2}{2E_z(\Omega^2 - E_z^2)} (g\mu_B b_{\perp})^2 - \frac{\varepsilon}{\Omega} g\mu_B b_z.$$

- fit $2t_c$

Rabi oscillations, Ramsey fringes



$$f_{\text{Rabi}} = 4t_c^2 g \mu_B b_{\perp} \Omega_c / \Omega |\Omega^2 - E_z^2|.$$

- $f_{\text{Rabi}} = 1.3$ MHz at zero detuning
- $f_{\text{Rabi}} = 0.13$ MHz at detuning 3.0 mV
- $T_2^{\text{Rabi}} = 5\text{-}7$ μs , almost constant
- $T_2^* = 0.42$ μs

Conclusions

- flopping-mode EDSR in Si-MOS
- one order of magnitude increase of f_{Rabi} at zero detuning
- measured $T2^*$ and $T2_{\text{Rabi}}$ almost independent of f_{Rabi}
- better performance for Ge heavy holes, phosphorus donor qubits